#### Last updated 3/1/21

Memory Taxonomy



- Flash Memory basics
  - Memory cell (1 bit) is based on charge stored on a floating capacitor
    - The capacitor modifies the threshold voltage of a MOSFET
      - with negative charge stored need higher gate voltage to turn on the MOSFET
    - Creates 2 possible threshold voltages

Different for NOR and NAND



- Flash Memory NOR
  - Cell write
    - High voltage process that allows electrons to be injected into the floating gate
- Hot-carrier injection gate oxide +9v S polysilicon +5v **0**v **Thick Oxide** Electrons  $\rightarrow$ n+ n+ p – Bulk Silicon tunnel oxide floating gate **0**v

- Flash Memory NOR
  - Cell erase
    - High voltage process that allows electrons to tunnel out of the floating gate
    - Fowler-Nordheim Tunneling



- Flash Memory NOR
  - Creates 2 possible threshold voltages
     Vth High is required to turn on the MOSFET if charge is stored
     Vth Low is required to turn on the MOSFET if no charge is stored



Flash Memory - NOR

#### Cell read

- Place a voltage on the gate midway between Vth High and Vth Low
- Use the circuit to determine if the MOSFET is on or off
- Erased state no charge stored = "1"
- Programmed state charge stored = "0"



- Flash Memory NOR
- Cell read Bit line Word Word Word Word Word Word line 0 line 1 line 2 line 3 line 5 line 4 OUT COMP Id MAT REF I/V I/V Vt0 Vt1 VREAD Vgs MREF VREAD **Vth**<sub>mid</sub>



- Flash Memory NAND
  - Basic cell
    - MOSFET with a small channel when  $V_{GS} = 0$
    - $V_{TH} < 0 nominally on$



- Flash Memory NAND
  - Cell write
    - High voltage process that allows electrons to tunnel into the floating gate
    - Fowler-Nordheim Tunneling



- Flash Memory NAND
  - Cell erase
    - High voltage process that allows electrons to tunnel out of the floating gate
    - Fowler-Nordheim Tunneling



- Flash Memory NAND
  - Creates 2 possible threshold voltages
     Vth >0 is required to turn on the MOSFET if charge is stored
     Vth <0 is required to turn on the MOSFET if no charge is stored</p>



Id /vt1 /vt2

- Flash Memory NAND
  - Cell read
    - Place 0v on the gate
    - Use the circuit to determine if the MOSFET is on or off
    - Erased state no charge stored = "1"
    - Programmed state charge stored = "0"



#### Flash Memory - NAND

- Cell read
  - All wordlines except the desired one set high (all other cells on)
  - Only the desired cell determines if current flows or not



- Flash Memory
  - Programming
    - All cells start out with no charge stored = "1"
    - Individual cells can be programmed to "0"
    - A block erase is required to change cells from "0" to "1"
    - Eg.
       byte: 1011 1100 → 1000 1100

byte: 1011 1100 > 1100 1100



Flash Memory

- NAND Flash
  - Page Write
  - Block Erase
  - More dense
  - Fast (required) sequential access
  - Used as file storage memory (Flash Drives)

- NOR Flash
  - Byte/word Write
  - Block Erase
  - Less dense
  - Fast random access
- Used as program memory

- Flash Memory
  - Nand Structure



- Flash Memory
  - Damage wear out
    - The tunneling process damages the oxide layer
      - Some electrons get trapped in the oxide
      - Physical damage to the lattice
    - Limits the number of write/erase cycles
      - 10K 1M cycles
    - Wear leveling
      - Remap the external addresses to new physical blocks on erases
      - Dynamic do this as changes occur
      - Static do this to little used blocks to make them available
        - Allows all blocks to approach their failure limit

- Flash Memory
  - Multi-Level Cell
    - Instead of just having 2 threshold voltages allow for 4 or 8
    - 4  $\rightarrow$  2 bit MLC, 8  $\rightarrow$  3bit MLC
  - All aspects of the design get harder (programming, read, wear leveling, speed) → ECC
  - Error Correction Coding ECC
    - Additional bits are used to detect and correct bit level errors in a word

- Flash Memory
  - Shadowing
    - Store large amounts of program and data in Nand Flash
    - At boot, copy a portion of the Nand memory into SRAM or SDRAM
    - Use the SRAM/SDRAM as the processor program and data memory
    - As additional program or data are needed swap out a portion of the SRAM/SDRAM



- Flash memory
  - XIP Execute in Place
    - Execute directly out of NOR flash
      - Nor Flash densities are growing rapidly
      - Nor Flash speeds are fast enough to support the memory hierarchy
      - Requires a caching system

- Other Technologies
  - Phase Change Memory PRAM
  - Ferro-Magnetic Ram FeRAM
  - Magneto-resistive Ram MRAM

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